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| INFORMATION DISCLOSURE STATEMENT BY APPLICANT PTO FORM 1449 | Atty. Docket No. 12301/2 | Serial No. 10/026,295 |
| | Applicant(s) Yamamoto et al. | |
| | Filing Date December 20, 2001 | Group Art Unit 1711 |
| | | |

U. S. PATENT DOCUMENTS

| EXAMINER'S INITIALS | PATENT NUMBER | PATENT DATE | NAME | CLASS | SUBCLASS | FILING DATE |
|---------------------|---------------|--------------|-------------------|-------|----------|-------------|
| th | 3,940,304 | Feb 24, 1976 | Schuler | | | |
| | 5,412,505 | May 2, 1995 | van Ligten et al. | | | |
| | 5,751,481 | May 12, 1998 | Dalzell et al. | | | |
| ✓ | 5,757,459 | May 26, 1998 | Bhalakia et al. | | | |
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FOREIGN PATENT DOCUMENTS

| EXAMINER'S INITIALS | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUB-CLASS | TRANSLATION | |
|---------------------|-----------------|-------------|---------|-------|-----------|-------------|----|
| | | | | | | YES | NO |
| th | JP 59-169820 A | 2 Feb. 1985 | JP | | | X* | |
| ✓ | WO 99/24243 | 20 May 1999 | WIPO | | | | |

* - English-language abstract provided.

OTHER DOCUMENTS

| EXAMINER'S INITIALS | | AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC. |
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| EXAMINER | <i>Thao Tran</i> | DATE CONSIDERED | <i>2/14/05</i> |
| EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. | | | |

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